

MPEG Clock Generator with VCXO

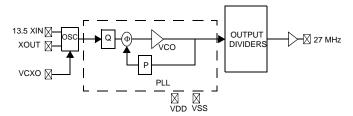
Features

- Integrated phase-locked loop (PLL)
- · Low-jitter, high-accuracy outputs
- · VCXO with analog adjust
- 3.3V operation
- Compatible with MK3727 (-1, -4)
- · Application compatibility for a wide variety of designs
- Enables design compatibility
- Lower drive strength settings (CY241V08A-04)

Benefits

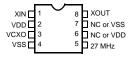
- Digital VCXO control
- · Second source for existing designs
- Highest-performance PLL tailored for multimedia applications
- Meets critical timing requirements in complex system designs

CY241V08A-01,-04 Logic Block Diagram



Pin Configurations

CY241V08A-01,-04 8-pin SOIC



Part Number	Outputs	Input Frequency Range	Output Frequencies	VCXO Control Curve	Other Features
CY241V08A-01		13.5-MHz pullable crystal input per Cypress specification	1 copy of 27 MHz	linear	Compatible with MK3727
CY241V08A-04		13.5-MHz pullable crystal input per Cypress specification	1 copy of 27 MHz		Same as CY241V08A-01 except lower drive strength settings



Pin Description

Name	Pin Number	Description
XIN	1	Reference crystal input
VDD	2	Voltage supply
VCXO	3	Input analog control for VCXO
VSS	4	Ground
27 MHz	5	27-MHz clock output
NC/VDD	6	No connect or voltage supply
NC/VSS	7	No connect or ground
XOUT	8	Reference crystal output



Absolute Maximum Conditions

(Above which the useful life may be impaired. For user guidelines, not tested.)

Supply Voltage (V_{DD})-0.5 to +7.0V DC Input Voltage –0.5V to V_{DD} + 0.5

Storage Temperature (Non-condensing) –55°C to +125°C
Junction Temperature40°C to +125°C
Data Retention @ Tj = 125°C > 10 years
Package Power Dissipation350 mW
ESD (Human Body Model) MIL-STD-883> 2000V

Pullable Crystal Specifications^[1]

Parameter	Description	Comments	Min.	Тур.	Max.	Unit
F _{NOM}	Nominal crystal frequency	Parallel resonance, fundamental mode, AT cut	_	13.5	-	MHz
C _{LNOM}	Nominal load capacitance		_	14	_	pF
R ₁	Equivalent series resistance (ESR)	Fundamental mode	_	_	25	Ω
R ₃ /R ₁	Ratio of third overtone mode ESR to fundamental mode ESR	Ratio used because typical R ₁ values are much less than the maximum spec	3	_	-	-
DL	Crystal drive level	No external series resistor assumed	150	_	_	μW
F _{3SEPHI}	Third overtone separation from 3*F _{NOM}	High side	300	_	-	ppm
F _{3SEPLO}	Third overtone separation from 3*F _{NOM}	Low side	_	_	-150	ppm
C ₀	Crystal shunt capacitance		_	_	7	pF
C ₀ /C ₁	Ratio of shunt to motional capacitance		180	_	250	-
C ₁	Crystal motional capacitance		14.4	18	21.6	fF

Recommended Operating Conditions

Parameter	Description	Min.	Тур.	Max.	Unit
VDD	Operating Voltage	3.135	3.3	3.465	V
T _A	Ambient Temperature	0	_	70	°C
C _{LOAD}	Max. Load Capacitance	_	_	15	pF
t _{PU}	Power-up time for all VDD pins to reach minimum specified voltage (power ramps must be monotonic)	0.05	-	500	ms

DC Electrical Specifications

Parameter	Name	Description	Min.	Тур.	Max.	Unit
I _{OH}	Output HIGH Current	$V_{OH} = V_{DD} - 0.5V, V_{DD} = 3.3V$	12	24	_	mA
I _{OL}	Output LOW Current	$V_{OL} = 0.5V, V_{DD} = 3.3V$	12	24	_	mA
C _{IN}	Input Capacitance	Except XIN, XOUT pins	_	_	7	pF
V_{VCXO}	VCXO Input Range		0	_	V_{DD}	V
f _{ΔXO} ^[2]	VCXO Pullability Range	Low Side	_	_	-115	ppm
		High Side	115	_	_	ppm
I_{VDD}	Supply Current		_	30	35	mA

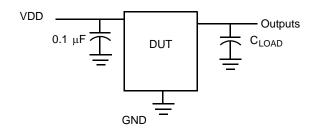
Crystals that meet this specification includes: Ecliptek ECX-5788-13.500M,Siward XTL001050A-13.5-14-400, Raltron A-13.500-14-CL,PDI HA13500XFSA14XC.
 -115/+115 ppm assumes 2.5pF of additional board level load capacitance. This range will be shifted down with more board capacitance or shifted up with less board capacitance.



AC Electrical Specifications ($V_{DD} = 3.3V$) [3]

Parameter ^[3]	Name	Description	Min.	Тур.	Max.	Unit
DC	Output Duty Cycle	Duty Cycle is defined in Figure 1, 50% of V _{DD}	45	50	55	%
ER _{OR}	Rising Edge Rate –01	Output Clock Edge Rate, Measured from 20% to 80% of V _{DD} , CLOAD = 15 pF See <i>Figure</i> 2.	0.8	1.4	-	V/ns
ER _{OF}	Falling Edge Rate –01	Output Clock Edge Rate, Measured from 80% to 20% of V _{DD} , CLOAD = 15 pF See <i>Figure</i> 2.	0.8	1.4	_	V/ns
ER _{OR}	Rising Edge Rate –04	Output Clock Edge Rate, Measured from 20% to 80% of V _{DD} , CLOAD = 15 pF See <i>Figure 2</i> .	0.7	1.1	-	V/ns
ER _{OF}	Falling Edge Rate –04	Output Clock Edge Rate, Measured from 80% to 20% of V _{DD} , CLOAD = 15 pF See <i>Figure 2</i> .	0.7	1.1	-	V/ns
t ₉	Clock Jitter	Peak-to-peak period jitter	_	_	100	ps
t ₁₀	PLL Lock Time		_	_	3	ms

Test and Measurement Set-up



Voltage and Timing Definitions

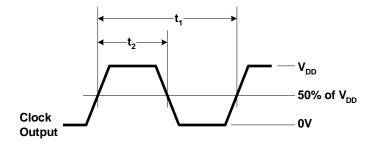


Figure 1. Duty Cycle Definition

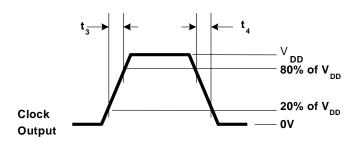


Figure 2. ER = $(0.6 \text{ x V}_{DD})/t_3$, EF = $(0.6 \text{ x V}_{DD})/t_4$

Note:

3. Not 100% tested.

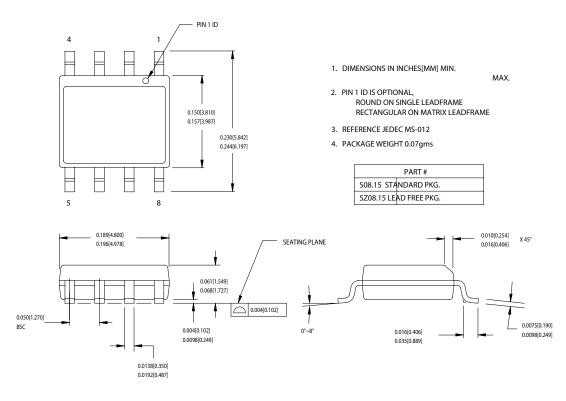


Ordering Information

Ordering Code	Package Type	Operating Range	Operating Voltage	Features
CY241V08ASC-01	8-pin SOIC	Commercial	3.3V	Linear VCXO control curve
CY241V08ASC-01T	8-pin SOIC – Tape and Reel	Commercial	3.3V	Linear VCXO control curve
CY241V08ASC-04	8-pin SOIC	Commercial	3.3V	Linear VCXO control curve
CY241V08ASC-04T	8-pin SOIC – Tape and Reel	Commercial	3.3V	Linear VCXO control curve
Lead-free				
CY241V8ASXC-01	8-pin SOIC	Commercial	3.3V	Linear VCXO control curve
CY241V8ASXC-01T	8-pin SOIC - Tape and Reel	Commercial	3.3V	Linear VCXO control curve

Package Drawing and Dimensions

8-lead (150-Mil) SOIC S8



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Document History Page

REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change
**	214069	See ECN	RGL	New Data Sheet
*A	220404	See ECN	RGL	Minor Change: To post on web
*B	393122	See ECN	RGL	Added Lead-free device for -01 Added the CY241V8A-01 in the title
*C	414184	See ECN	RGL	Minor Change: Deleted unneccesary text in the benefit section

Document #: 38-07656 Rev. *C